

Ultra Series[™] Crystal Oscillator Si546 Data Sheet

Ultra Low Jitter Dual Any-Frequency XO (80 fs), 0.2 to 1500 MHz

The Si546 Ultra Series[™] oscillator utilizes Skyworks Solutions' advanced 4th generation DSPLL® technology to provide an ultra-low jitter, low phase noise clock at two selectable frequencies. The device is factory-programmed to provide any two selectable frequencies from 0.2 to 1500 MHz with <1 ppb resolution and maintains exceptionally low jitter for both integer and fractional frequencies across its operating range. The Si546 offers excellent reliability and frequency stability as well as guaranteed aging performance. On-chip power supply filtering provides industry-leading power supply noise rejection. simplifying the task of generating low litter clocks in noisy systems that use switched-mode power supplies. Offered in industry-standard footprints, the Si546 has a dramatically simplified supply chain that enables Skyworks to ship custom frequency samples 1-2 weeks after receipt of order. Unlike a traditional XO, where a different crystal is required for each output frequency, the Si546 uses one simple crystal and a DSPLL IC-based approach to provide the desired output frequencies. This process also guarantees 100% electrical testing of every device. The Si546 is factory-configurable for a wide variety of user specifications, including frequency, output format, and OE pin location/polarity. Specific configurations are factory-programmed at time of shipment, eliminating the long lead times associated with custom oscillators.

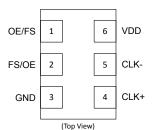
Pin Assignments



5 x 7 mm and 3.2 x 5 mm







Pin #	Descriptions
1, 2	Selectable via ordering option OE = Output enable; FS = Frequency Select
3	GND = Ground
4	CLK+ = Clock output
5	CLK- = Complementary clock output. Not used for CMOS.
6	VDD = Power supply

KEY FEATURES

- · Available with any two selectable frequencies from 200 kHz to 1500 MHz
- · Ultra low jitter: 80 fs Typ RMS (12 kHz - 20 MHz)
- Excellent PSNR and supply noise immunity: -80 dBc Typ
- 7 ppm stability option (-40 to 85 °C)
- 3.3 V, 2.5 V and 1.8 V V_{DD} supply operation from the same part number
- · LVPECL, LVDS, CML, HCSL, CMOS, and **Dual CMOS output options**
- 2.5x3.2, 3.2x5, 5x7 mm package options
- Samples available with 1-2 week lead times

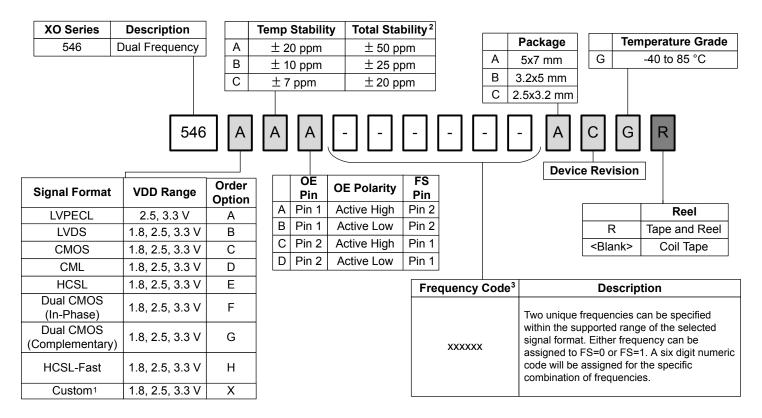
APPLICATIONS

- 100G/200G/400G OTN, coherent optics
- · 10G/25G/40G/100G Ethernet
- · 3G-SDI/12G-SDI/24G-SDI broadcast video
- Servers, switches, storage, NICs, search acceleration
- Test and measurement
- · Clock and data recovery
- FPGA/ASIC clocking

Fixed Frequency Crystal	Frequency Flexible DSPLL	Low Noise
OSC Digital Phase Detector NVM Control Pow	Phase Error Cancellation Phase Error Phase Error Fractional Divider er Supply Regulation	Flexible Formats, 1.8V - 3.3V Operation
OE, Frequency S (Pin Control)		

1. Ordering Guide

The Si546 XO supports a variety of options including frequency, output format, and OE pin location/polarity, as shown in the chart below. Specific device configurations are programmed into the part at time of shipment, and samples are available in 1-2 weeks. Skyworks Solutions provides an online part number configuration utility to simplify this process. Refer to https://www.skyworksinc.com/en/Products/Timing to access this tool and for further ordering instructions.



Notes:

- 1. Contact Skyworks for non-standard configurations.
- 2. Total stability includes temp stability, initial accuracy, load pulling, VDD variation, and 20 year aging at 70 °C.
- Create custom part numbers at https://www.skyworksinc.com/en/Products/Timing.

1.1 Technical Support

Oscillator Phase Noise Lookup Utility	https://www.skyworksinc.com/tools/oscillator-phase-noise		
Quality and Reliability	https://www.skyworksinc.com/quality		
Development Kits	https://www.skyworksinc.com/en/Products/Timing		

2. Electrical Specifications

Table 2.1. Electrical Specifications

 V_{DD} = 1.8 V, 2.5 or 3.3 V ± 5%, T_A = –40 to 85 °C

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Temperature Range	T _A		-40	_	85	°C
requency Range T_A requency Range F_{CLK} Supply Voltage V_{DD} Supply Current I_{DD} remperature Stability remperature Stability Factor F_{STAB}	LVPECL, LVDS, CML	0.2	_	1500	MHz	
		HCSL	0.2	_	400	MHz
		LVPECL, LVDS, CML	250	MHz		
Supply Voltage	V _{DD}	3.3 V	3.135	3.3	3.465	V
		2.5 V	2.375	2.5	2.625	V
		1.8 V	1.71	1.8	1.89	V
Supply Current	I _{DD}	LVPECL (output enabled)	_	107	153	mA
		LVDS/CML (output enabled)	_	83	121	mA
		HCSL (output enabled)	_	86	126	mA
		HCSL-Fast (output enabled)	_	94	138	mA
		CMOS (output enabled)	_	87	127	mA
		Dual CMOS (output enabled)	_	92	141	mA
		Tristate Hi-Z (output disabled)	_	73	112	mA
Temperature Stability		Frequency stability Grade A	-20	_	20	ppm
		Frequency stability Grade B	-10	_	10	ppm
		Frequency stability Grade C	-7	_	7	ppm
Total Stability ¹	F _{STAB}	Frequency stability Grade A	-50	_	50	ppm
		Frequency stability Grade B	-25	_	25	ppm
		Frequency stability Grade C	-20	_	20	ppm
Rise/Fall Time	T _R /T _F	LVPECL/LVDS/CML	_	_	350	ps
(20% to 80% V _{PP})		CMOS / Dual CMOS, (C _L = 5 pF)	_	0.5	1.5	ns
		HCSL, F _{CLK} >50 MHz	_	_	550	ps
		HCSL-Fast, F _{CLK} >50 MHz	_	_	275	ps
Duty Cycle	D _C	All formats	45	_	55	%
Output Enable (OE)	V _{IH}		0.7 × V _{DD}	_	_	V
Frequency Select (FS) ²	V _{IL}		_	_	0.3 × V _{DD}	V
	T _D	Output Disable Time, F _{CLK} >10 MHz	_	_	3	μs
	T _E	Output Enable Time, F _{CLK} >10 MHz	_	_	20	μs
	T _{FS}	Settling Time after FS Change	_	_	10	ms
Powerup Time	tosc	Time from 0.9 × V _{DD} until output frequency (F _{CLK}) within spec	_		100	ms

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Powerup V _{DD} Ramp Rate	V_{RAMP}	Fastest VDD ramp rate allowed on startup	_	_	100	V/ms
LVPECL Output Option ³	V _{OC}	Mid-level	V _{DD} – 1.42	_	V _{DD} – 1.25	V
	Vo	Swing (diff)	1.1	_	1.9	V_{PP}
LVDS Output Option ⁴			1.125	1.20	1.275	V
		Mid-level (1.8 V VDD)		0.9	1.0	V
	V _O Swing (F _{CLK} ≤ 1.4 GHz)		0.6	0.7	0.9	V_{PP}
		Swing (F _{CLK} > 1.4 GHz)	0.5	0.7	0.9	V_{PP}
HCSL Output Option ⁵	V _{OH}	Output voltage high	660	750	850	mV
HCSL-Fast Output Option ⁵	V _{OL}	Output voltage low	-150	0	150	mV
	V _C	Crossing voltage	250	350	550	mV
CML Output Option (AC-Coupled)	Vo	Swing (diff)	0.6	0.8	1.0	V_{PP}
CMOS Output Option	V _{OH}	I _{OH} = 8/6/4 mA for 3.3/2.5/1.8 V VDD	0.85 × V _{DD}	_	_	V
	V _{OL}	I _{OL} = 8/6/4 mA for 3.3/2.5/1.8 V VDD	_	_	0.15 × V _{DD}	V

- 1. Total Stability includes temperature stability, initial accuracy, load pulling, VDD variation, and aging for 20 yrs at 70 °C.
- 2. OE includes a 50 k Ω pull-up to VDD for OE active high. Includes a 50 k Ω pull-down to GND for OE active low. FS includes a 50 k Ω pull-up to VDD.
- 3.50 Ω to V_{DD} 2.0 V. Additional DC current from the output driver will flow through the 50 Ω resistors, resulting in a shift in common mode voltage. The measurements in this table have accounted for this.
- 4. R_{term} = 100 Ω (differential).
- 5.50 Ω to GND.

Table 2.2. Clock Output Phase Jitter and PSNR

 V_{DD} = 1.8 V, 2.5 or 3.3 V ± 5%, T_A = -40 to 85 °C

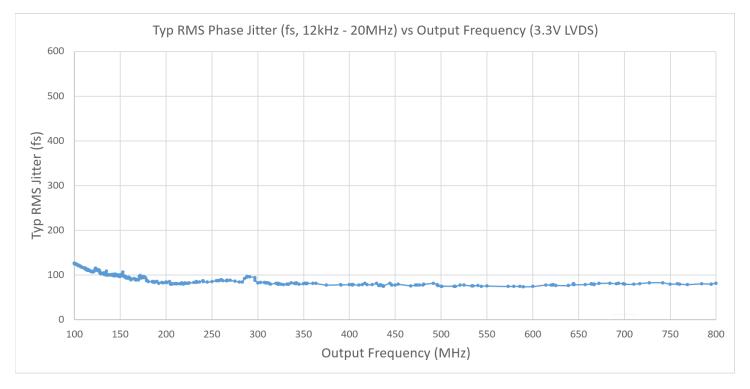
Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Phase Jitter (RMS, 12kHz - 20MHz) ¹	фЈ	F _{CLK} ≥ 200 MHz		80	110	fs
3.2 x 5 mm, All Differential Formats		100 MHz ≤ F _{CLK} < 200 MHz	_	100	150	fs
		LVPECL @ 156.25 MHz	_	90	125	fs
Phase Jitter (RMS, 12kHz - 20MHz) ¹	фл	F _{CLK} ≥ 200 MHz	_	80	130	fs
5 x 7 mm, All Differential Formats		100 MHz ≤ F _{CLK} < 200 MHz	_	100	150	fs
		LVPECL @ 156.25 MHz	_	90	125	fs
Phase Jitter (RMS, 12kHz - 20MHz) ¹	фЈ	F _{CLK} ≥ 200 MHz	_	90	130	fs
2.5 x 3.2 mm, All Differential Formats		LVDS @ 625 MHz	_	90	130	fs
		100 MHz ≤ F _{CLK} < 200 MHz	_	100	150	fs
Phase Jitter (RMS, 12kHz - 20MHz) ¹ CMOS / Dual CMOS Formats	фл	10 MHz ≤ F _{CLK} ≤ 250 MHz	_	200	_	fs
Spurs Induced by External Power Supply	PSNR	100 kHz sine wave	_	-83	_	
Noise, 50 mVpp Ripple. LVDS 156.25 MHz Output		200 kHz sine wave	_	-83	_	dDa
		500 kHz sine wave	_	-82	_	dBc
		1 MHz sine wave	_	-85	_	

Note:

1. Guaranteed by characterization. Jitter inclusive of any spurs.

Table 2.3. 3.2 x 5 mm, Clock Output Phase Noise (Typical, 50 ppm Total Stability Option)

Offset Frequency (f)	156.25 MHz LVDS	200 MHz LVDS	644.53125 MHz LVDS	Unit
100 Hz	-106	-102	-92	
1 kHz	–133	–129	–119	
10 kHz	-140	–138	-127	
100 kHz	–145	-142	-132	dBc/Hz
1 MHz	– 152	–150	–139	
10 MHz	-160	-160	-154	
20 MHz	– 161	– 161	–155	
Offset Frequency (f)	156.25 MHz LVPECL	200 MHz LVPECL	644.53125 MHz LVPECL	Unit
100 Hz	-103	-104	– 91	
1 kHz	-130	–128	–118	
10 kHz	-140	-138	–127	
100 kHz	–145	-142	-132	dBc/Hz
1 MHz	– 152	–150	-140	
10 MHz	-162	-162	–155	
20 MHz	-163	-163	-156	



Phase jitter measured with Agilent E5052 using a differential-to-single ended converter (balun or buffer). Measurements collected for >700 commonly used frequencies. Phase noise plots for specific frequencies are available using our free, online Oscillator Phase Noise Lookup Tool at https://www.skyworksinc.com/tools/oscillator-phase-noise.

Figure 2.1. Phase Jitter vs. Output Frequency

Table 2.4. Environmental Compliance and Package Information

Parameter	Test Condition
Mechanical Shock	MIL-STD-883, Method 2002
Mechanical Vibration	MIL-STD-883, Method 2007
Solderability	MIL-STD-883, Method 2003
Gross and Fine Leak	MIL-STD-883, Method 1014
Resistance to Solder Heat	MIL-STD-883, Method 2036
Moisture Sensitivity Level (MSL): 3.2 x 5, 5 x 7 packages	1
Moisture Sensitivity Level (MSL): 2.5 x 3.2 package	2
Contact Pads: 3.2x5, 5x7 packages	Au/Ni (0.3 - 1.0 μm / 1.27 - 8.89 μm)
Contact Pads: 2.5x3.2 packages	Au/Pd/Ni (0.03 - 0.12 μm / 0.1 - 0.2 μm / 3.0 - 8.0 μm)

Note:

Table 2.5. Thermal Conditions

Max Junction Temperature = 125° C

Package	Parameter	Symbol	Test Condition	Value	Unit
	Thermal Resistance Junction to Ambient	Θ_{JA}	Still Air, 85 °C	80	°C/W
2.5 x 3.2 mm 6-pin DFN	Thermal Parameter Junction to Board	Ψ_{JB}	Still Air, 85 °C	39	°C/W
·	Thermal Parameter Junction to Top Center	$\Psi_{ m JT}$	Still Air, 85 °C	17	°C/W
	Thermal Resistance Junction to Ambient	Θ _{JA}	Still Air, 85 °C	55	°C/W
3.2 × 5 mm 6-pin CLCC	Thermal Parameter Junction to Board	Ψ_{JB}	Still Air, 85 °C	20	°C/W
, p	Thermal Parameter Junction to Top Center	$\Psi_{ m JT}$	Still Air, 85 °C	20	°C/W
	Thermal Resistance Junction to Ambient	Θ _{JA}	Still Air, 85 °C	53	°C/W
5 × 7 mm 6-pin CLCC	Thermal Parameter Junction to Board	Ψ_{JB}	Still Air, 85 °C	26	°C/W
•	Thermal Parameter Junction to Top Center	Ψ_{JT}	Still Air, 85 °C	26	°C/W

For additional product information not listed in the data sheet (e.g. RoHS Certifications, MDDS data, qualification data, REACH Declarations, ECCN codes, etc.), refer to our "Corporate Request For Information" portal found here: www.skyworksinc.com/quality.

^{1.} Based on PCB Dimensions: 4.5" x 7", PCB Thickness: 1.6 mm, Number of Cu Layers: 4.

Table 2.6. Absolute Maximum Ratings¹

Parameter	Symbol	Rating	Unit
Maximum Operating Temp.	T _{AMAX}	95	°C
Storage Temperature	T _S	-55 to 125	°C
Supply Voltage	V _{DD}	-0.5 to 3.8	°C
Input Voltage	V _{IN}	-0.5 to V _{DD} + 0.3	V
ESD HBM (JESD22-A114)	НВМ	2.0	kV
Solder Temperature ²	T _{PEAK}	260	°C
Solder Time at T _{PEAK} ²	T _P	20–40	sec

- 1. Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.
- 2. The device is compliant with JEDEC J-STD-020.

3. Dual CMOS Buffer

Dual CMOS output format ordering options support either complementary or in-phase signals for two identical frequency outputs. This feature enables replacement of multiple XOs with a single Si546 device.

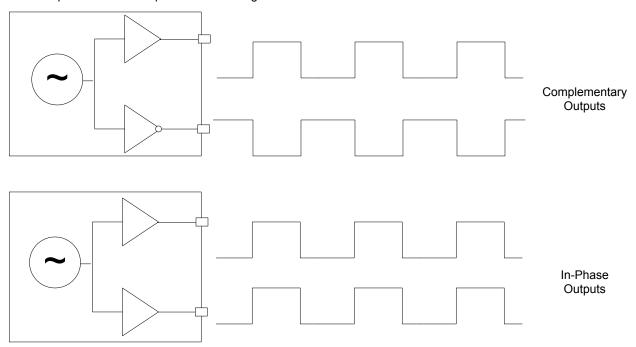


Figure 3.1. Integrated 1:2 CMOS Buffer Supports Complementary or In-Phase Outputs

4. Recommended Output Terminations

The output drivers support both AC-coupled and DC-coupled terminations as shown in figures below.

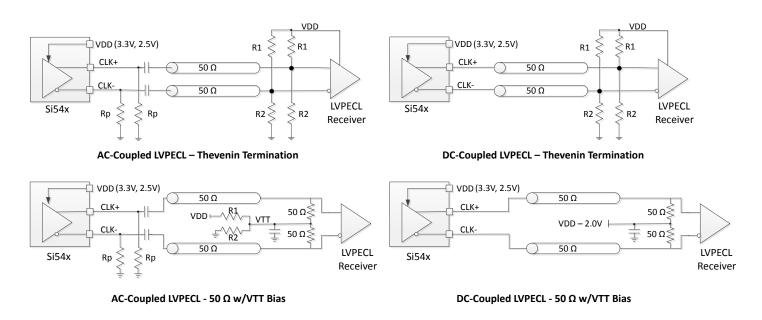


Figure 4.1. LVPECL Output Terminations

AC Coupled LVPECL Termination Resistor Values					DC Coupled LVPECL mination Resistor Val	
VDD	R1	R2	Rp	VDD R1 R2		
3.3 V	82.5 Ω	127 Ω	130 Ω	3.3 V	127 Ω	82.5 Ω
2.5 V	62.5 Ω	250 Ω	90 Ω	2.5 V	250 Ω	62.5 Ω

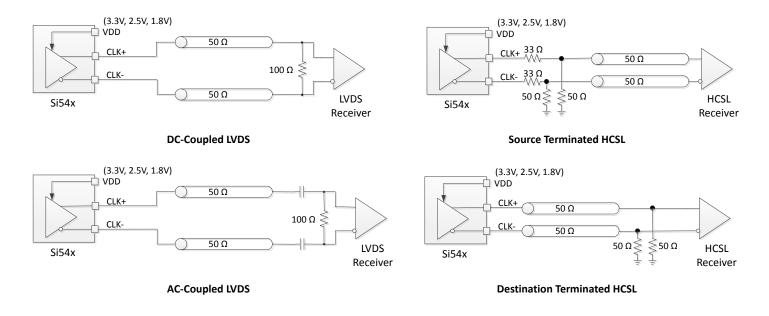


Figure 4.2. LVDS and HCSL Output Terminations

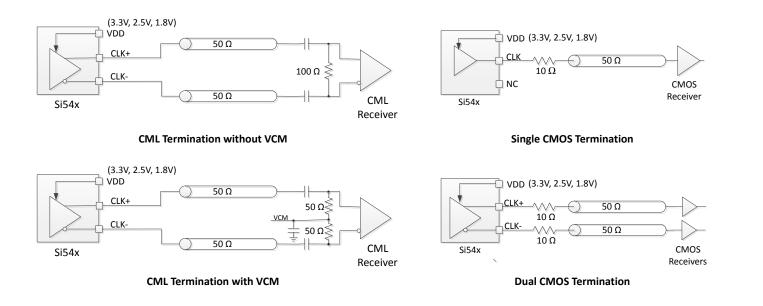


Figure 4.3. CML and CMOS Output Terminations

5. Package Outline

5.1 Package Outline (5×7 mm)

The figure below illustrates the package details for the 5×7 mm Si546. The table below lists the values for the dimensions shown in the illustration.

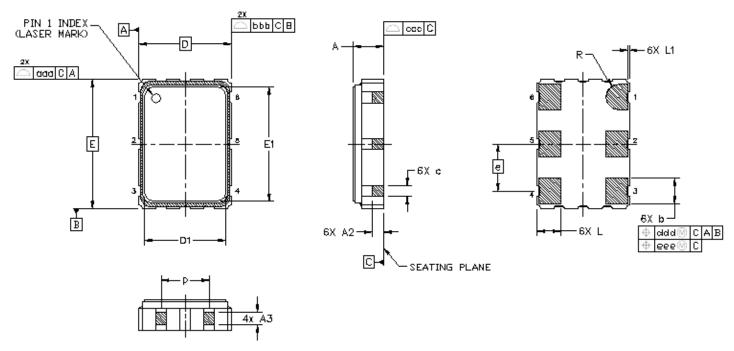


Figure 5.1. Si546 (5×7 mm) Outline Diagram

Table 5.1. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max		Dimension	Min	Nom	Max
А	1.13	1.28	1.43		L	1.17	1.27	1.37
A2	0.50	0.55	0.60		L1	0.05	0.10	0.15
A3	0.50	0.55	0.60		р	1.70	_	1.90
b	1.30	1.40	1.50		R	0.70 REF		
С	0.50	0.60	0.70		aaa	0.15		
D		5.00 BSC			bbb		0.15	
D1	4.30	4.40	4.50		ccc		0.08	
е		2.54 BSC			ddd	0.10		
E		7.00 BSC			eee	0.05		
E1	6.10	6.20	6.30					

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

5.2 Package Outline (3.2×5 mm)

The figure below illustrates the package details for the 3.2×5 mm Si546. The table below lists the values for the dimensions shown in the illustration.

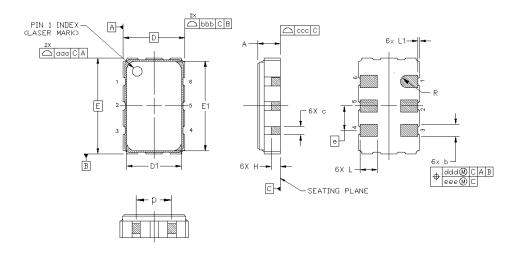


Figure 5.2. Si546 (3.2×5 mm) Outline Diagram

Table 5.2. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	1.06	1.17	1.33
b	0.54	0.64	0.74
С	0.35	0.45	0.55
D	3.20 BSC		
D1	2.55	2.60	2.65
е	1.27 BSC		
E	5.00 BSC		
E1	4.35	4.40	4.45
Н	0.45	0.55	0.65
L	0.80	0.90	1.00
L1	0.05	0.10	0.15
р	1.36	1.46	1.56
R	0.32 REF		
aaa	0.15		
bbb	0.15		
ccc	0.08		
ddd	0.10		
eee	0.05		

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

5.3 Package Outline (2.5x3.2 mm)

The figure below illustrates the package details for the 2.5x3.2 mm Si546. The table below lists the values for the dimensions shown in the illustration.

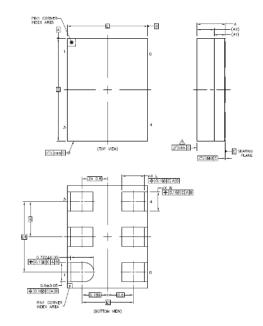


Figure 5.3. Si546 (2.5×3.2 mm) Outline Diagram

Table 5.3. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	0.85	0.90	1.00
A1		0.36 REF	
A2	0.53 REF		
W	0.55	0.60	0.65
D	3.2 BSC		
E	2.5 BSC		
е	1.10 BSC		
L	0.65	0.70	0.75
n	5		
D1	2.2 BSC		
E1	1.589 BSC		
aaa	0.10		
bbb	0.10		
ddd	0.08		

- 1. The dimensions in parentheses are reference.
- 2. All dimensions in millimeters (mm).
- 3. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

6. PCB Land Pattern

6.1 PCB Land Pattern (5×7 mm)

The figure below illustrates the 5×7 mm PCB land pattern for the Si546. The table below lists the values for the dimensions shown in the illustration.

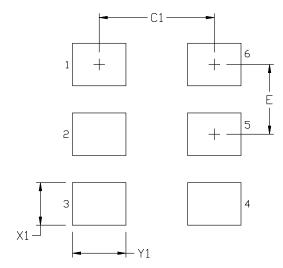


Figure 6.1. Si546 (5×7 mm) PCB Land Pattern

Table 6.1. PCB Land Pattern Dimensions (mm)

Dimension	(mm)
C1	4.20
E	2.54
X1	1.55
Y1	1.95

Notes:

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be $60 \mu m$ minimum, all the way around the pad.

Stencil Design

- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6.2 PCB Land Pattern (3.2×5 mm)

The figure below illustrates the 3.2×5.0 mm PCB land pattern for the Si546. The table below lists the values for the dimensions shown in the illustration.

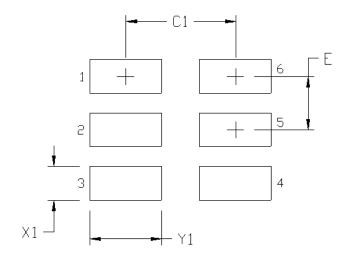


Figure 6.2. Si546 (3.2×5 mm) PCB Land Pattern

Table 6.2. PCB Land Pattern Dimensions (mm)

Dimension	(mm)
C1	2.60
E	1.27
X1	0.80
Y1	1.70

Notes:

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6.3 PCB Land Pattern (2.5×3.2 mm)

The figure below illustrates the 2.5×3.2 mm PCB land pattern for the Si546. The table below lists the values for the dimensions shown in the illustration.

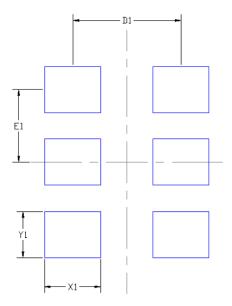


Figure 6.3. Si546 (2.5×3.2 mm) PCB Land Pattern

Table 6.3. PCB Land Pattern Dimensions (mm)

Dimension	Description	Value (mm)
X1	Width - leads on long sides	0.85
Y1	Height - leads on long sides	0.7
D1	Pitch in X directions of XLY1 leads	1.639
E1	Lead pitch XLY1 leads	1.10

Notes: The following notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine-tune their SMT process as required for their application and tooling.

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be $60 \mu m$ minimum, all the way around the pad.

Stencil Design

- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 0.8:1 for the pads.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

7. Top Marking

The following sections illustrate the top mark specifications for the Si546. The tables list the line information.

7.1 Top Marking (5x7 and 3.2x5 Packages)

The figure below illustrates the mark specification for the Si546 5x7 and 3.2x5 package sizes. The table below lists the line information.

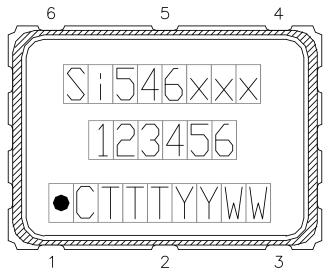


Figure 7.1. Mark Specification

Table 7.1. Si546 Top Mark Description

Line	Position	Description
1	1–8	"Si546", xxx = Ordering Option 1, Option 2, Option 3 (e.g. Si546AAA)
2	1–6	Frequency Code (6-digit custom code as described in the Ordering Guide)
3	Trace Code	
	Position 1	Pin 1 orientation mark (dot)
	Position 2	Product Revision (C)
	Position 3–5	Tiny Trace Code (3 alphanumeric characters per assembly release instructions)
	Position 6–7	Year (last two digits of the year), to be assigned by assembly site (ex: 2017 = 17)
	Position 8–9	Calendar Work Week number (1–53), to be assigned by assembly site

7.2 Top Marking (2.5x3.2 Package)

The figure below illustrates the mark specification for the Si546 2.5x3.2 package size. The table below lists the line information.

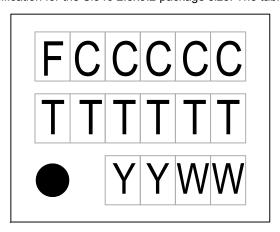


Figure 7.2. Mark Specification

Table 7.2. Si546 Top Mark Description

Line	Position	Description
1	1–6	F = Si546, CCCCC = Custom Mark Code
2	Trace Code	
	1–6	6 digit trace code per assembly release instructions
3	Position 1	Pin 1 orientation mark (dot)
	Position 2–3	Year (last two digits of the year), to be assigned by assembly site (ex: 2017 = 17)
	Position 4–5	Calendar Work Week number (1–53), to be assigned by assembly site

8. Revision History

Revision 206614A

May, 2023

• Updated Min and Nom package diagram dimensions specs in 5.3 Package Outline (2.5x3.2 mm).

Revision 1.3

June, 2021

- Updated Ordering Guide and topmark for RevC silicon
- · Added HCSL-Fast (faster tR/tF) ordering option
- · Updated Table 2.1, Powerup VDD Ramp Rate

Revision 1.2

September, 2020

- Added 2.5x3.2 mm package option.
- · Updated Table 2.1, Powerup VDD Ramp Rate and LVDS Swing

Revision 1.0

July, 2018

· Added 20 ppm total stability option.

Revision 0.75

March. 2018

· Added 25 ppm total stability option.

Revision 0.71

December 11, 2017

· Added 5x7 package and land pattern.

Revision 0.7

June 27, 2017

· Initial release.





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